

**Notice of References Cited**

Application/Control No.

10/501,737

Applicant(s)/Patent Under  
Reexamination  
KANNAN ET AL.

Examiner

Dwan A. Gerido, Ph.D.

Art Unit

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Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,716,477	04-2004	Komiyama et al.	427/8
*	B	US-5,569,837	10-1996	Hinaga, Yasushi	73/19.01
*	C	US-2003/0185966	10-2003	Kim et al.	427/8
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
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**NON-PATENT DOCUMENTS**

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